

# SIMULATION & DIGITAL TWIN IN TEST WAFER MANAGEMENT

Dr.-Ing. Karl-Benedikt Reith

Member of

**SCIO**  
AUTOMATION

**AIMS**<sup>5.0</sup>



**FABMATICS**



# AGENDA

1. Motivation
2. Three Levels of Analysis
3. Material Flow Simulation
4. Digital Twin
5. Use Case: Test Wafer Center

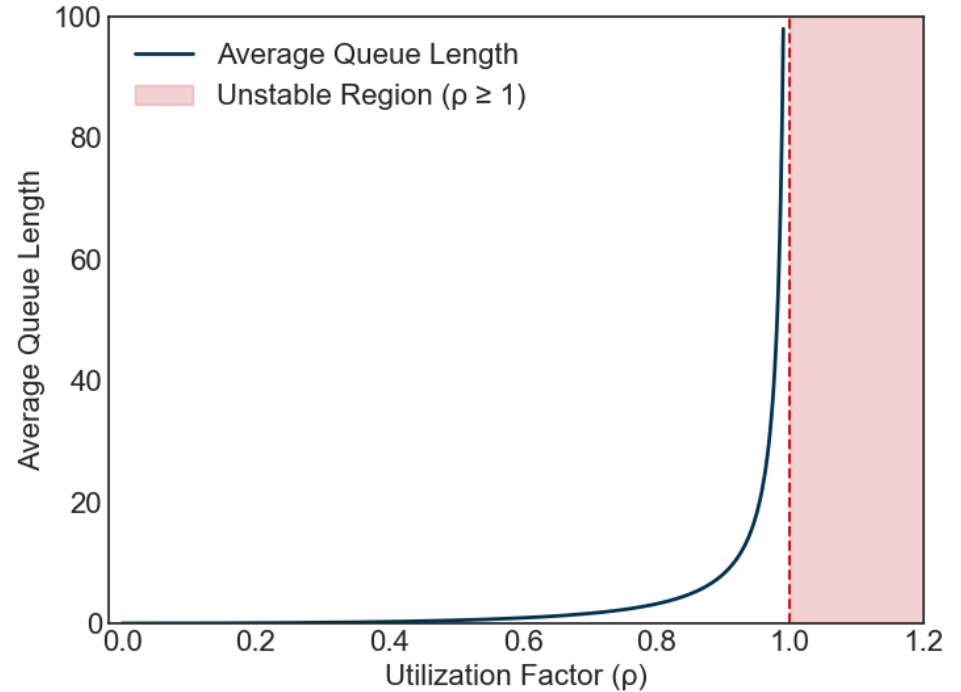
# WHY SYSTEM ANALYSIS IS CRUCIAL



Complex real-world processes often behave unexpectedly!

## Analysis allows for:

- ▶ understanding system dynamics
- ▶ preventing instability
- ▶ optimizing resource allocation
- ▶ quantifying trade-offs
- ▶ support strategic decision-making

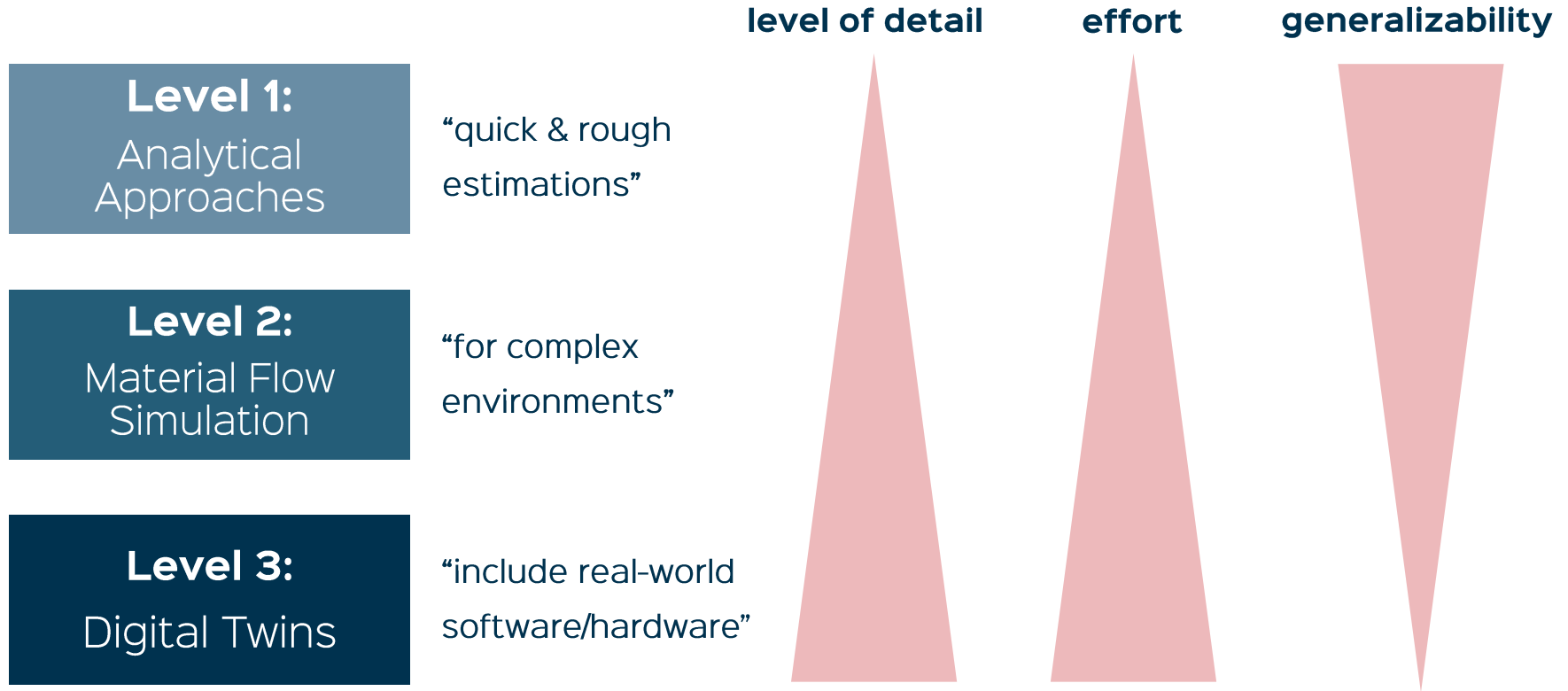


**Minimal Example:** Average queue length in front of a single service station (M/M/1).

# LEVELS OF ANALYSIS



How to assess general solutions or specific details of a solution?



# OBJECTIVES IN TEST WAFER MANAGEMENT



## Objectives: The TW Management...

- ▶ provides a sufficient test wafer supply
- ▶ guarantees high tool uptimes
- ▶ is robust to different product patterns
- ▶ is well arranged & organized
- ▶ has a smooth startup
- ▶ can adapt to future changes
- ▶ is economically justifiable

### Material Flow Simulation

→ Are TW built as needed?

→ Do TW reach tools in time?

→ Do TW always reach tools in time?

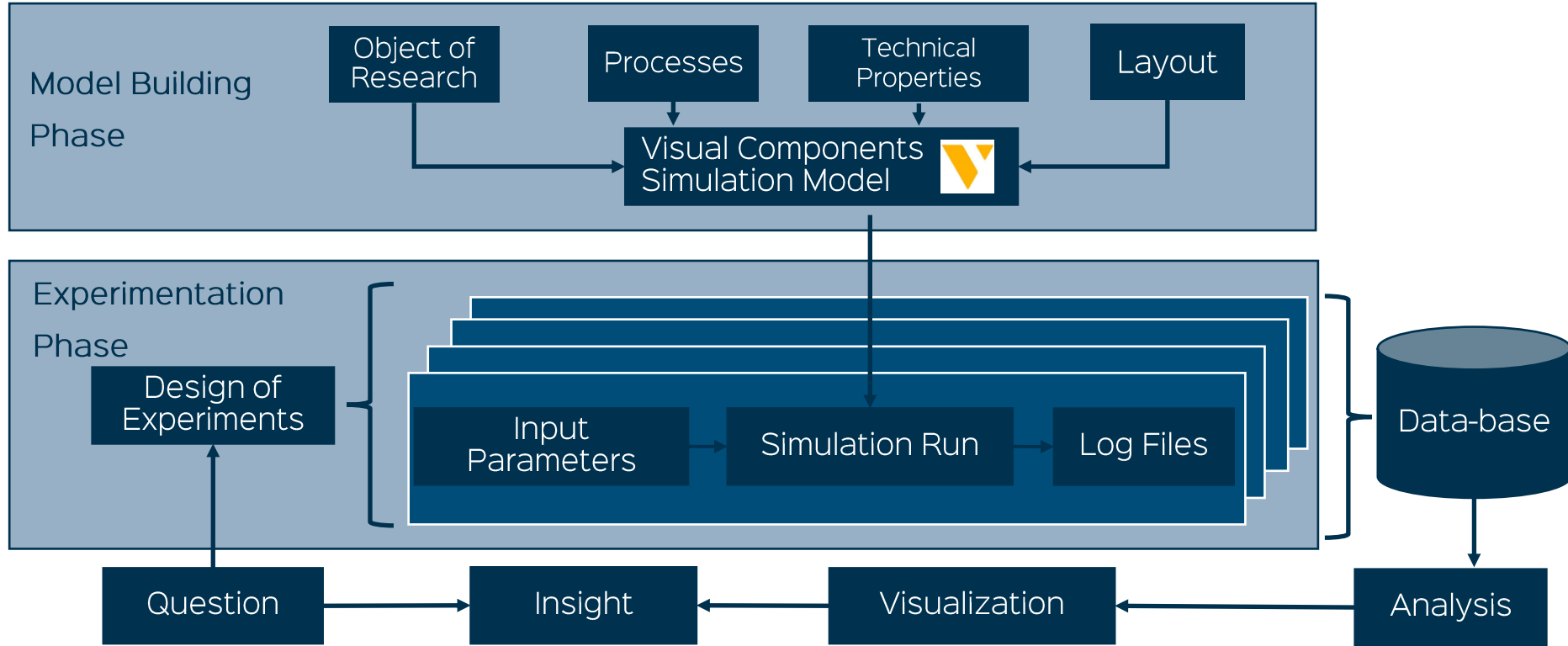
→ How much sorting & storage capacity do we need?

→ Can it be quickly integrated into the MES?

→ How flexible is my hardware?

### Digital Twin

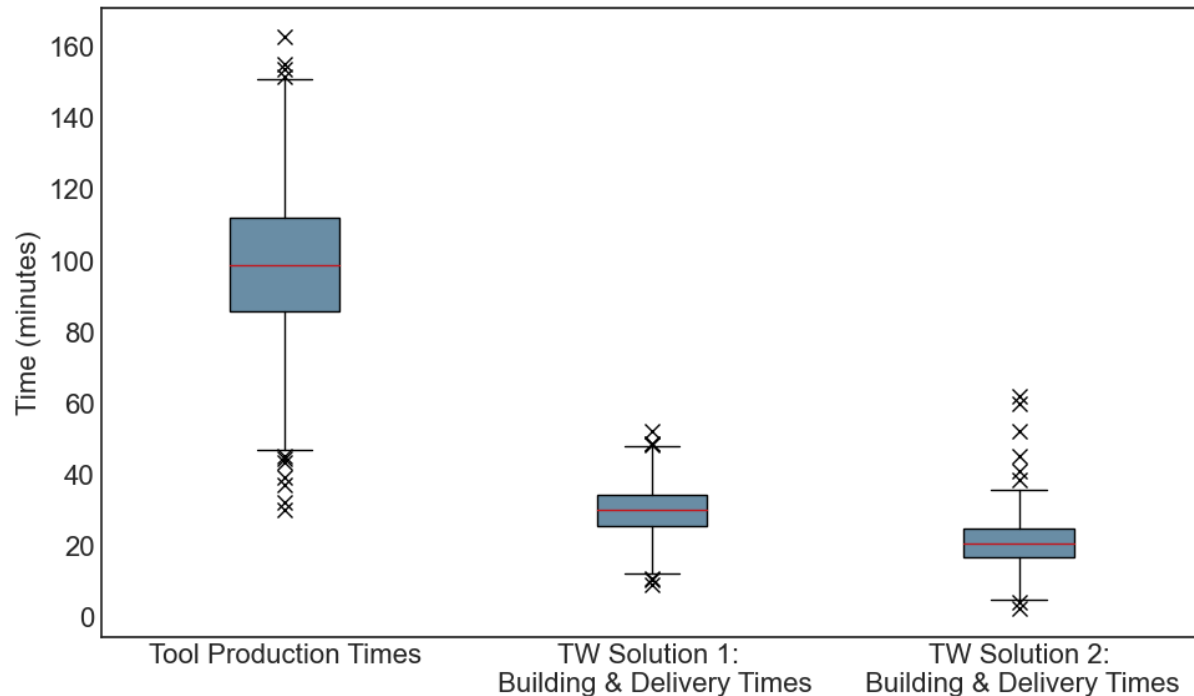
# MATERIAL FLOW SIMULATION WORKFLOW



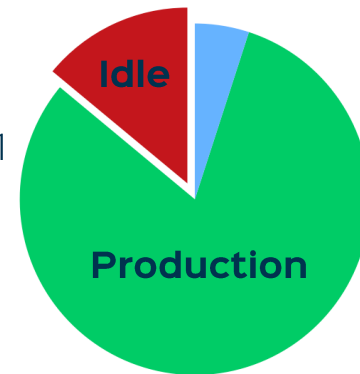
# TYPICAL RESULTS OF A SIMULATION STUDY 1



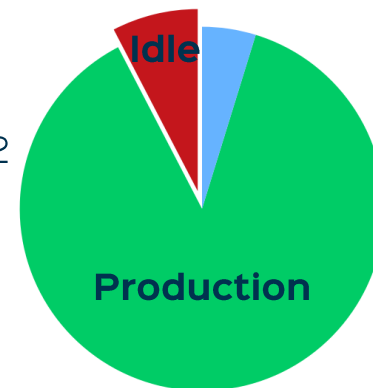
Representative example plots



Solution 1



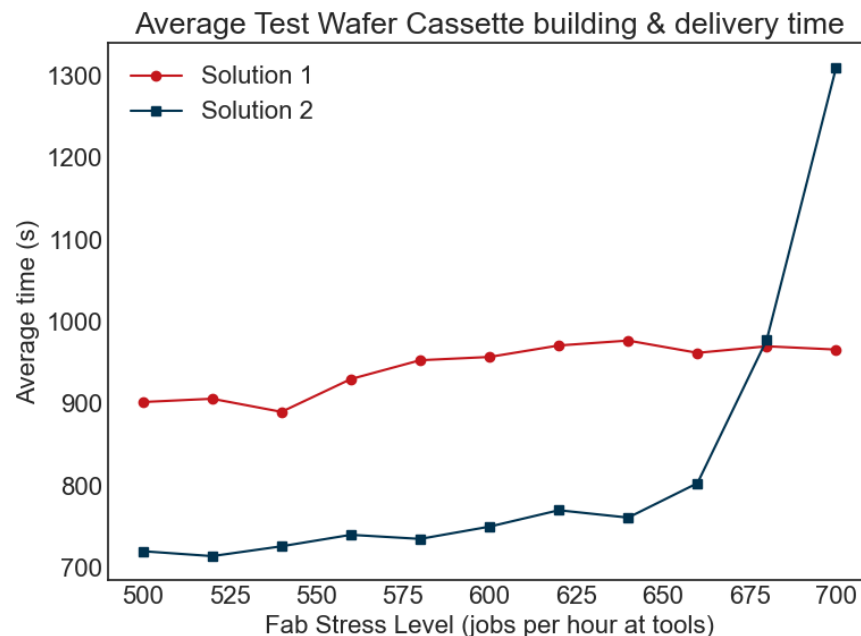
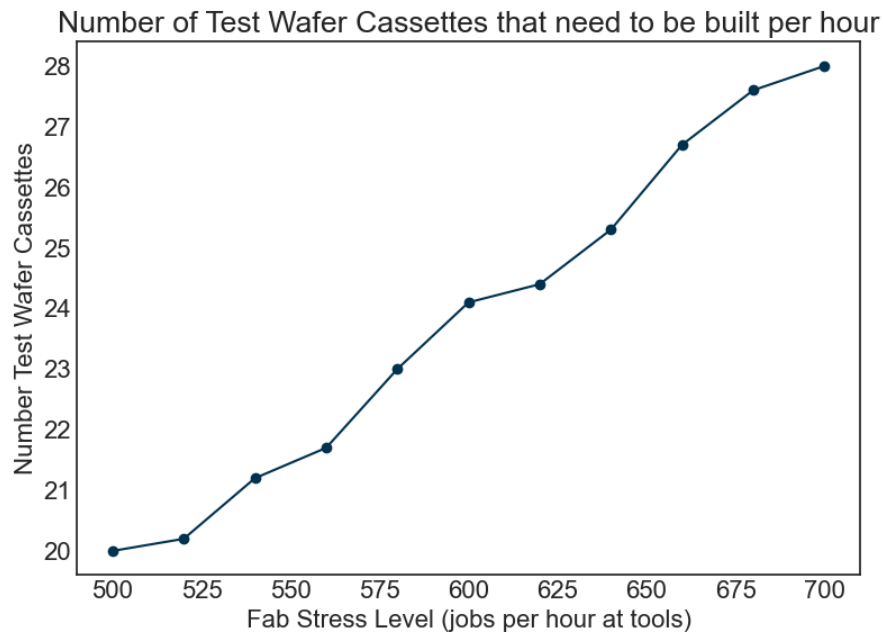
Solution 2



Tool E10 States

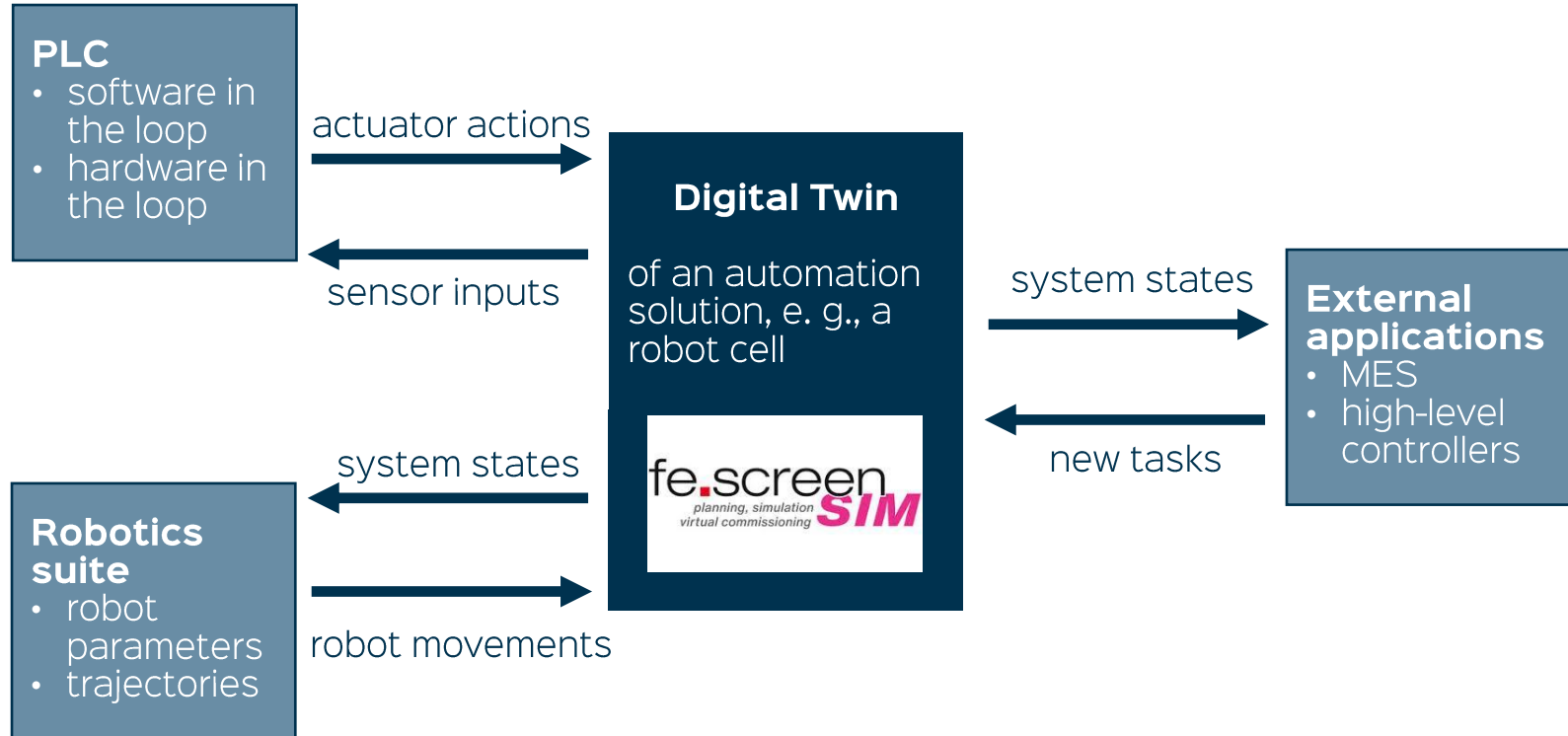
# TYPICAL RESULTS OF A SIMULATION STUDY 2

Representative example plots





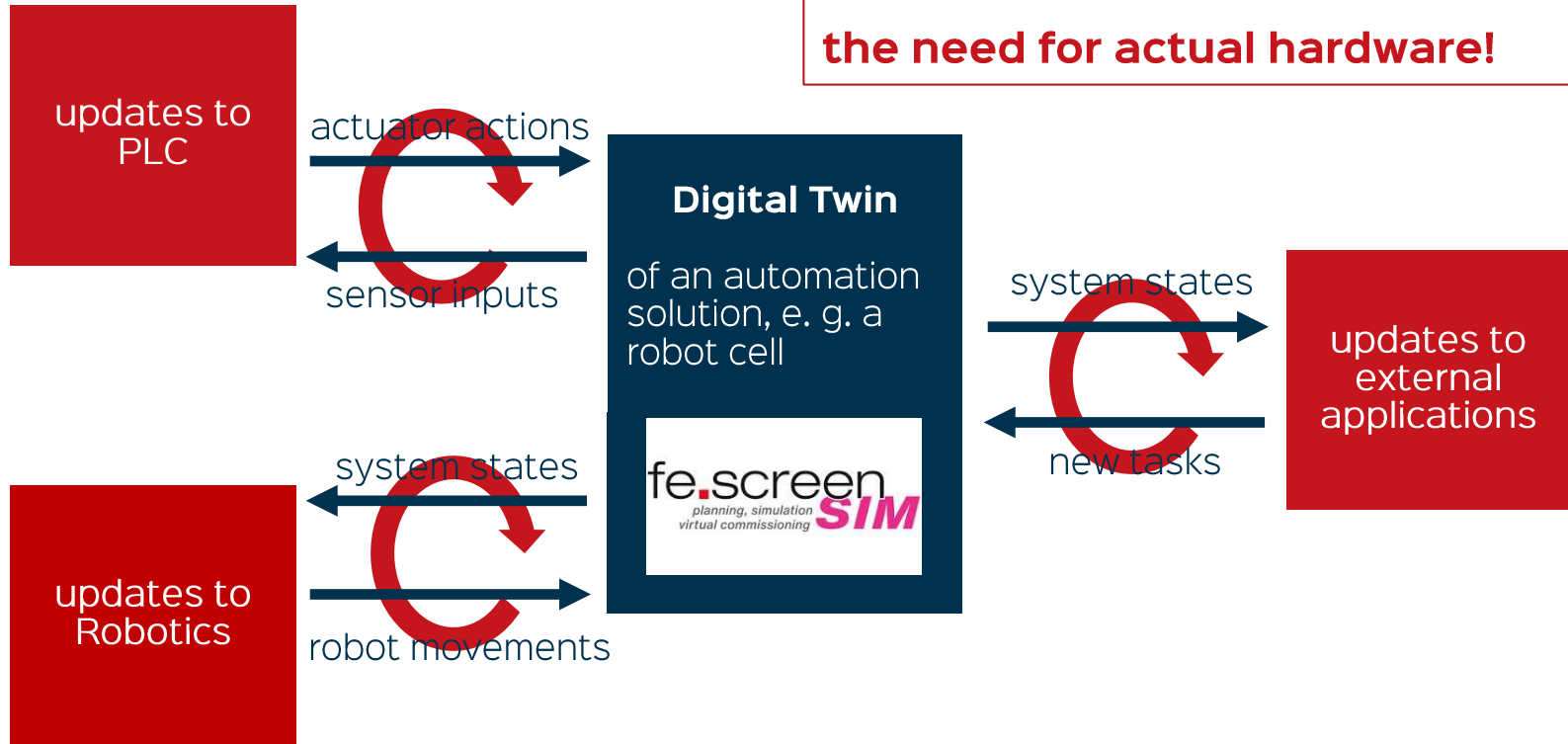
# DIGITAL TWIN WORKFLOW



# DIGITAL TWIN WORKFLOW



**Quick and valid feedback without  
the need for actual hardware!**

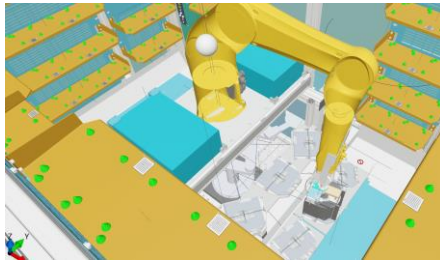


# BENEFITS OF A DIGITAL TWIN



## Equipment-centered view

- ▶ development/enhancement of software without the need for hardware components
- ▶ first software tests on the digital twin (especially helpful for moving elements)
- ▶ allows to have a digital twin for each generation of a hardware



## Customer-centered view

- ▶ allows a pre-delivery integration of the digital twin into a customer's system architecture for testing

# USE CASE: TEST WAFER CENTER



An example for an automated solution for stocker integrated test wafer sorting.

## Main Components

- ▶ 6-axis robot for carrier handling
- ▶ wafer handling robot
- ▶ shelves on each side for carrier storage
- ▶ up to 14 sorter ports

## Main Applications

- ▶ storage & sorting of test-wafers
- ▶ composition & re-sorting of new test lots
- ▶ adding and removing dummy wafers
- ▶ available also for HA200 boxes (box opener!)



# SUMMARY & MAIN TAKEAWAYS



- ▶ A sophisticated analysis is essential to evaluate complex systems (especially in automation projects).
- ▶ Three complementary levels of analysis (analytical, simulation, and digital twin), which work together seamlessly to provide comprehensive insights.
- ▶ Analytical approaches provide quick, preliminary results for rough estimations.
- ▶ Material flow simulation delivers precise, quantitative results for complex processes, enabling informed decision-making.
- ▶ Digital twins accelerate time-to-market, ensure seamless integration, and support flexible long-term usage of new equipments.



# THANK YOU

**Fabmatics GmbH**

Zur Steinhöhe 1  
01109 Dresden / Germany  
+49 351 65237-0  
info@fabmatics.com  
www.fabmatics.com

